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Application/Control No.	Applicant(s)/Patent under Reexamination
10/042,103	ALLEN ET AL.
Examiner	Art Unit
Jude J. Jean-Gilles	2143

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709	201-203 204 211-213	10/11/2005	JG
711	146 117 146	10/11/2005	JG
712	10 203 32	10/11/2005	1G
710	100	10/11/2005	1G

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	[ ]	Subclass Date

SEARCH (INCLUDING SEAF	NOTES RCH STRATEGY	)	
DATE		EXMR	
PAM tool: Effective Filing Date Double Patenting	10/11/2005	1Ġ	
EAST Tool: DERWENT USPAT EPO JPO	10/11/2005	JG	
Internet tool: google.com NPLs IEEE onelook.com	10/11/2005	JG	